

<b>Notice of References Cited</b>	Application/Control No. 10/630,714	Applicant(s)/Patent Under Reexamination YOSHIDA, KEISUKE	
	Examiner Pierre-Michel Bataille	Art Unit 2186	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0023707	01-2003	Ryan, Fintan	709/220
*	B	US-7,117,482	10-2006	Nguyen et al.	717/122
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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**NON-PATENT DOCUMENTS**

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